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FIN1019

3.3V LVDS High Speed Differential Driver/Receiver

General Description

This driver and receiver pair are designed for high speed interconnects utilizing Low Voltage Differential Signaling (LVDS) technology. The driver translates LVTTL signals to LVDS levels with a typical differential output swing of 350mV and the receiver translates LVDS signals, with a typical differential input threshold of 100mV, into LVTTL levels. LVDS technology provides low EMI at ultra low power dissipation even at high frequencies. This device is ideal for high speed clock or data transfer.

Features

- Greater than 400Mbs data rate
- 3.3V power supply operation
- 0.5ns maximum differential pulse skew
- 2.5ns maximum propagation delay
- Low power dissipation
- Power-Off protection
- 100mV receiver input sensitivity
- Fail safe protection open-circuit, shorted and terminated conditions
- Meets or exceeds the TIA/EIA-644 LVDS standard
- Flow-through pinout simplifies PCB layout
- 14-Lead SOIC and TSSOP packages save space

Ordering Code:

Order Number	Package Number	Package Description	
FIN1019M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow	- 3
FIN1019MTC	MTC14	14-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wid	le

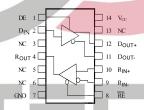
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Function Table

Inputs			Out	Outputs		
R _{IN+}	R _{IN+} R _{IN-}		Ro	R _{OUT}		
L	H	L				
Н	L	L		+		
Х	Х	Н		Z		
Fail Safe	Condition	L		F _		
D _{IN}		DE	D _{OUT+}	D _{OUT}		
L		Н	1	H		
Н		Н	Н	L		
X	- N	L	Z	Z		
Open-Circui	it or Z	Н	L	Н		

H = HIGH Logic Level L = LOW Logic Level X = Don't Care Z = High Impedance Fail Safe = Open, Shorted, Terminated

Connection Diagram



Pin Descriptions

Pin Name	Description
D _{IN}	LVTTL Data Input
D _{OUT+}	Non-inverting LVDS Output
D _{OUT}	Inverting LVDS Output
DE	Driver Enable (LVTTL, Active HIGH)
R _{IN+}	Non-Inverting LVDS Input
R _{IN}	Inverting LVDS Input
R _{OUT}	LVTTL Receiver Output
RE	Receiver Enable (LVTTL, Active LOW)
V _{CC}	Power Supply
GND	Ground
NC	No Connect

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DS500506

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Absolute Maximum Ratings(Note 1)

 $\label{eq:Storage Temperature Range (T_{STG})} \\ \text{Max Junction Temperature (T}_{J}) \\ \text{Lead Temperature (T}_{L}) \\ \\$

 (Soldering, 10 seconds)
 260°C

 ESD (Human Body Model)
 ≥ 6500V

 ESD (Machine Model)
 ≥ 300V

Recommended Operating Conditions

Supply Voltage (V_{CC}) 3.0V to 3.6V Input Voltage (V_{IN}) 0 to V_{CC}

Magnitude of Differential Voltage

 $\begin{array}{ll} (|V_{ID}|) & 100 \text{ mV to V}_{CC} \\ \text{Common-Mode Input Voltage } (V_{IC}) & 0.05 \text{V to } 2.35 \text{V} \\ \text{Operating Temperature } (T_{A}) & -40 ^{\circ}\text{C to } +85 ^{\circ}\text{C} \\ \end{array}$

Note 1: The "Absolute Maximum Ratings": are those values beyond which damage to the device may occur. The databook specifications should be met, without exception, to ensure that the system design is reliable over its power supply, temperature and output/input loading variables. Fairchild does not recommend operation of circuits outside databook specification.

DC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

-65°C to +150°C

150°C

Symbo	Parameter	Test Conditions	Min	Typ (Note 2)	Max	Units
LVDS Dif	ferential Driver Characteristics					
V _{OD}	Output Differential Voltage		250	350	450	mV
ΔV_{OD}	V _{OD} Magnitude Change from				25	mV
	Differential LOW-to-HIGH	$R_L = 100\Omega$, See Figure 1			23	1117
Vos	Offset Voltage		1.125	1.25	1.375	V
ΔV _{OS}	Offset Magnitude Change from				25	mV
	Differential LOW-to-HIGH				25	III V
I _{OZD}	Disabled Output Leakage Current	$V_{OUT} = V_{CC}$ or GND, DE = 0V		/	±20	μΑ
I _{OFF}	Power Off Output Current	V _{CC} = 0V, V _{OUT} = 0V or 3.6V			±20	μΑ
Ios	Short Circuit Output Current	$V_{OUT} = 0V$, DE = V_{CC}			-8	mA
		$V_{OD} = 0V$, $DE = V_{CC}$			±8	IIIA
LVTTL D	river Characteristics					7
V _{OH}	Output HIGH Voltage	$I_{OH} = -100 \mu\text{A}, \overline{\text{RE}} = 0\text{V},$	4			-
		See Figure 6 and Table 1	V _{CC} -0.2			
		$I_{OH} = -8 \text{ mA}, \overline{RE} = 0V, V_{ID} = 400 \text{ mV}$	1			V
		$V_{ID} = 400 \text{ mV}, V_{IC} = 1.2 \text{V}, \text{ see Figure 6}$	2.4			
		_				
V _{OL}	Output LOW Voltage	$I_{OL} = 100 \mu\text{A}, \text{RE} = 0\text{V}, \text{V}_{\text{ID}} = -400 \text{mV}$			0.2	
		See Figure 6 and Table 1				V
		$I_{OL} = -8 \text{ mA}, \overline{RE} = 0V, V_{ID} = -400 \text{ mV}$			0.5	
		$V_{ID} = -400 \text{ mV}, V_{IC} = 1.2 \text{V}, \text{ see Figure 6}$			0.0	
loz	Disabled Output Leakage Current	$V_{OUT} = V_{CC}$ or GND, $\overline{RE} = V_{CC}$			±20	μА
LVDS Re	ceiver Characteristics	FIFO		0.0		0
V _{TH}	Differential Input Threshold HIGH	See Figure 6 and Table 1		T U	100	mV
V _{TL}	Differential Input Threshold LOW	See Figure 6 and Table 1	-100			mV
I _{IN}	Input Current	V _{IN} = 0V or V _{CC}			±20	μΑ
I _{I(OFF)}	Power-OFF Input Current	V _{CC} = 0V, V _{IN} = 0V or 3.6V			±20	μΑ
. ,	river and Control Signals Characteristic	cs				
V _{IH}	Input HIGH Voltage		2.0		V _{CC}	V
V _{IL}	Input LOW Voltage		GND		0.8	V
I _{IN}	Input Current	V _{IN} = 0V or V _{CC}	1		±20	μА
I _{I(OFF)}	Power-OFF Input Current	V _{CC} = 0V, V _{IN} = 0V or 3.6V			±20	μA
V _{IK}	Input Clamp Voltage	I _{IK} = -18 mA	-1.5			V

DC Electrical Characteristics (Continued) Device Characteristics Power Supply Current Driver Enabled, Driver Load: $R_L = 100 \Omega$ I_{CC} 12.5 Receiver Disabled, No Receiver Load Driver Enabled, Driver Load: $R_L = 100 \Omega$, Receiver Enabled, (R $_{IN+} = 1 \text{V}$ and R $_{IN-} = 1.4 \text{V})$ 12.5 mΑ or (R_{IN+} = 1.4V and R_{OUT-} = 1V) Driver Disabled, Receiver Enabled, $(R_{IN+} = 1V \text{ and } R_{IN-} = 1.4V) \text{ or }$ 7.0 mΑ $(R_{IN+}\,{=}\,1.4V$ and $R_{IN-}\,{=}\,1V)$ Driver Disabled, Receiver Disabled 7.0 mΑ Input Capacitance Any LVTTL or LVDS Input pF Cout Output Capacitance Any LVTTL or LVDS Output 6 pF

Note 2: All typical values are at $T_A = 25$ °C and with $V_{CC} = 3.3$ V.

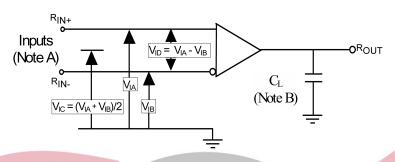
AC Electrical Characteristics

Over supply voltage and operating temperature ranges, unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Typ (Note 3)	Max	Units
Driver Timi	ng Characteristics					
t _{PLHD}	Differential Propagation Delay LOW-to-HIGH		0.5		1.5	ns
t _{PHLD}	Differential Propagation Delay HIGH-to-LOW	$R_L = 100 \Omega, C_L = 10 pF,$	0.5		1.5	ns
t _{TLHD}	Differential Output Rise Time (20% to 80%)	See Figure 2 and Figure 3	0.4		1.0	ns
t _{THLD}	Differential Output Fall Time (80% to 20%)		0.4		1.0	ns
t _{SK(P)}	Pulse Skew t _{PLH} - t _{PHL}				0.5	ns
t _{SK(PP)}	Part-to-Part Skew (Note 4)				1.0	ns
t _{ZHD}	Differential Output Enable Time from Z to HIGH	$R_L = 100\Omega$, $C_L = 10 pF$,			5.0	ns
t _{ZLD}	Differential Output Enable Time from Z to LOW	See Figure 4 and Figure 5			5.0	ns
t _{HZD}	Differential Output Disable Time from HIGH to Z				5.0	ns
t _{LZD}	Differential Output Disable Time from LOW to Z				5.0	ns
Receiver Ti	ming Characteristics					
t _{PLH}	Propagation Delay LOW-to-HIGH		0.9		2.5	ns
t _{PHL}	Propagation Delay HIGH-to-LOW		0.9		2.5	ns
t _{TLH}	Output Rise time (20% to 80%)	$ V_{ID} = 400 \text{ mV}, C_L = 10 \text{ pF},$		0.5		ns
t _{THL}	Output Fall time (80% to 20%)	See Figure 6 and Figure 7		0.5		ns
t _{SK(P)}	Pulse Skew t _{PLH} - t _{PHL}				0.5	ns
t _{SK(PP)}	Part-to-Part Skew (Note 4)				1.0	ns
t _{ZH}	LVTTL Output Enable Time from Z to HIGH				5.0	ns
t _{ZL}	LVTTL Output Enable Time from Z to LOW	$R_L = 500 \Omega$, $C_L = 10 pF$,			5.0	ns
t _{HZ}	LVTTL Output Disable Time from HIGH to Z	See Figure 8			5.0	ns
t _{LZ}	LVTTL Output Disable Time from LOW to Z			100000000000000000000000000000000000000	5.0	ns

Note 3: All typical values are at $T_A = 25$ °C and with $V_{CC} = 5V$.

Note 4: t_{SK(PP)} is the magnitude of the difference in propagation delay times between any specified terminals of two devices switching in the same direction (either LOW-to-HIGH or HIGH-to-LOW) when both devices operate with the same supply voltage, same temperature, and have identical test circuits.



Note A: Input pulses have frequency = 10 MHz, t_R or t_F = 1ns

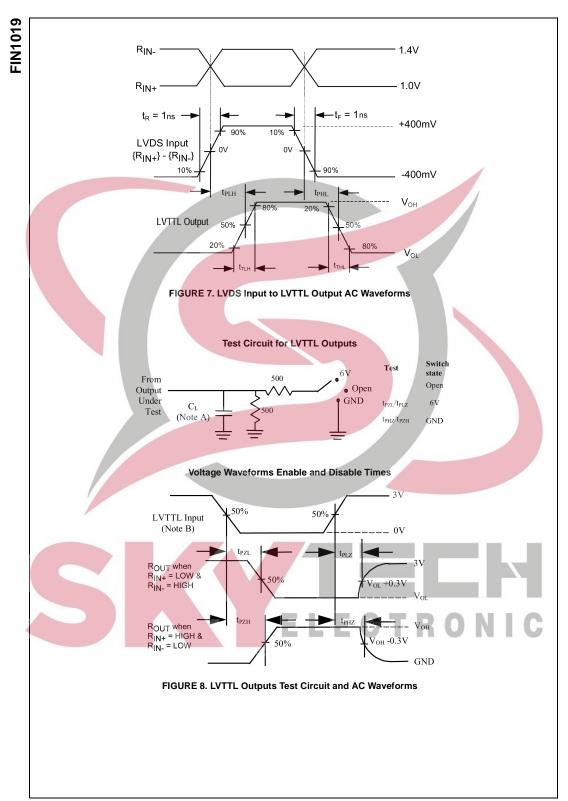
Note B: C_L includes all probe and fixture capacitance

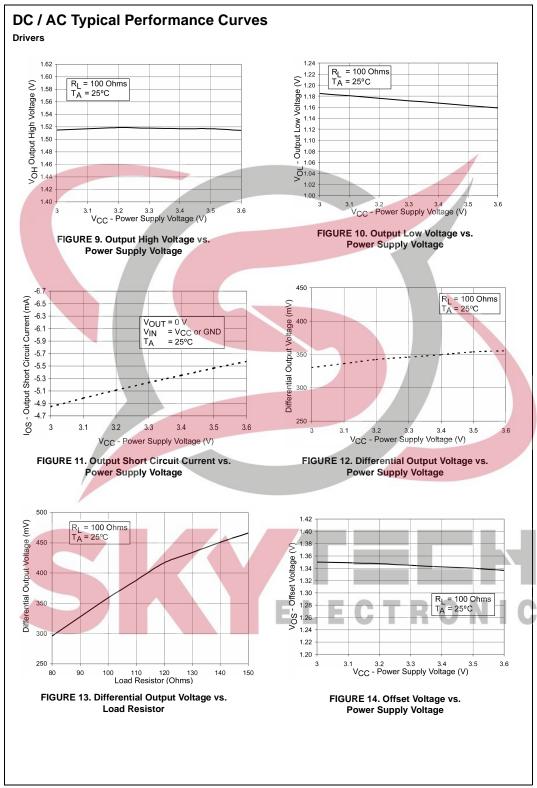
FIGURE 6. Differential Receiver Voltage Definitions and Propagation Delay and Transition Time Test Circuit

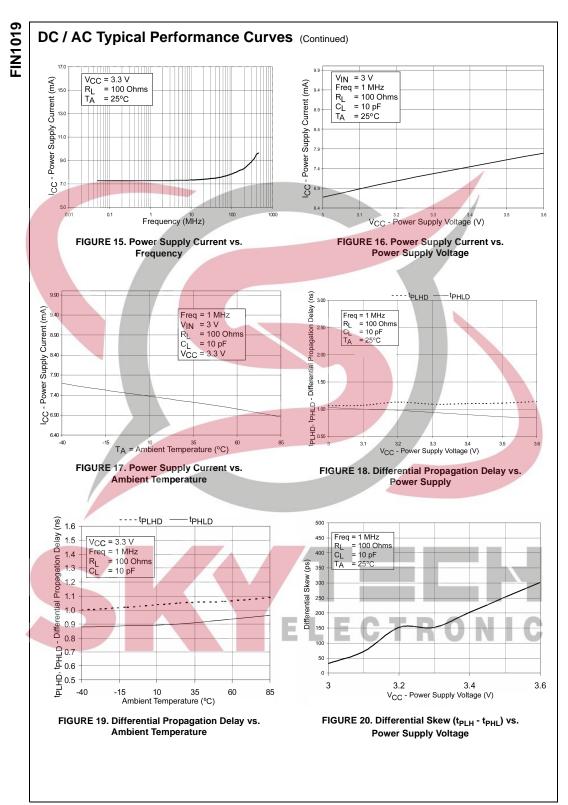
TABLE 1. Receiver Minimum and Maximum Input Threshold Test Voltages

Applied Vo		Resulting Differential Input Voltage (mV)	Resulting Common Mode Input Voltage (V)
Applied Voltages (V)			
VIA	V _{IB}	V _{ID}	V _{IC}
1.25	1.15	100	1.2
1.15	1.25	-100	1.2
2.4	2.3	100	2.35
2.3	2.4	-100	2.35
0.1	0	100	0.05
0	0.1	-100	0.05
1.5	0.9	600	1.2
0.9	1.5	-600	1.2
2.4	1.8	600	2.1
1.8	2.4	-600	2.1
0.6	0	600	0.3
0	0.6	-600	0.3

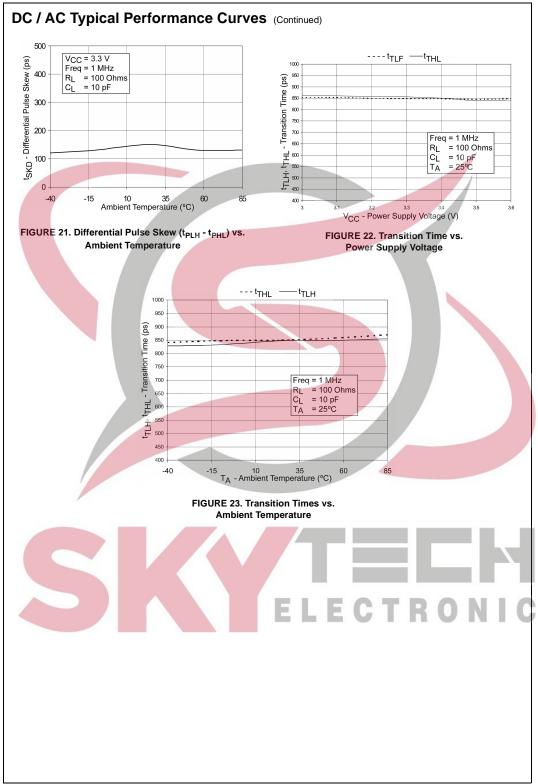


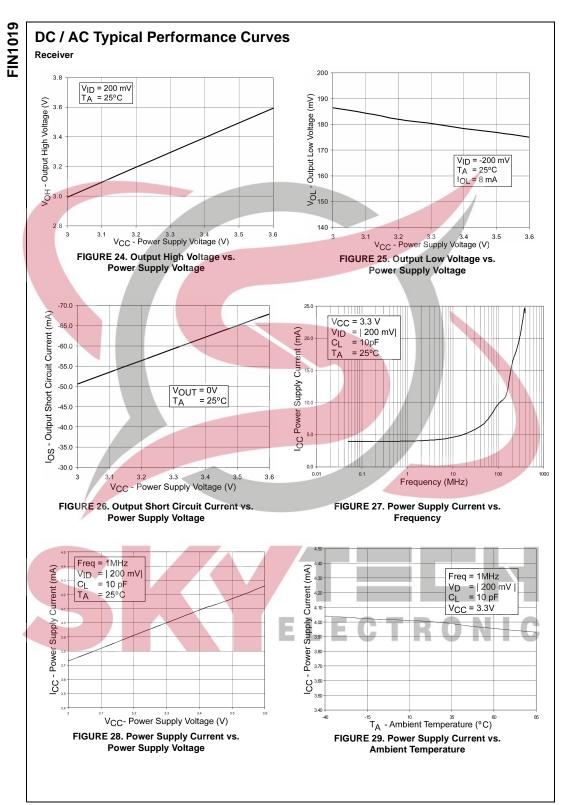


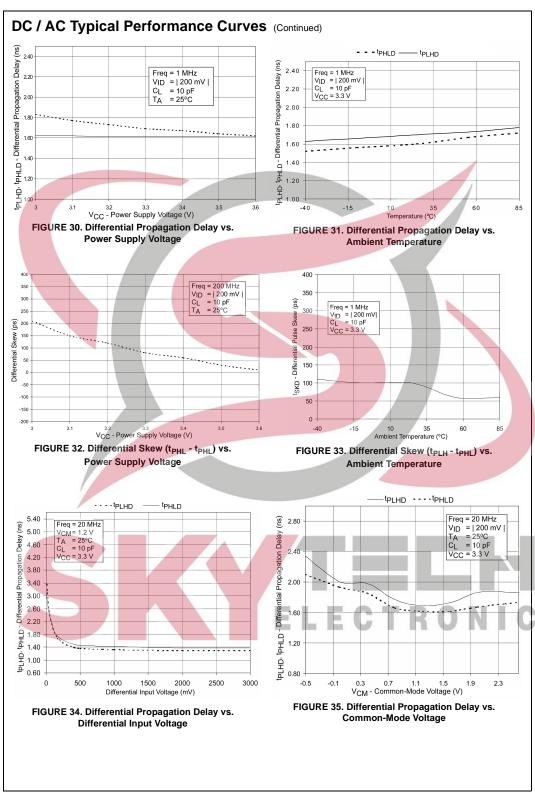


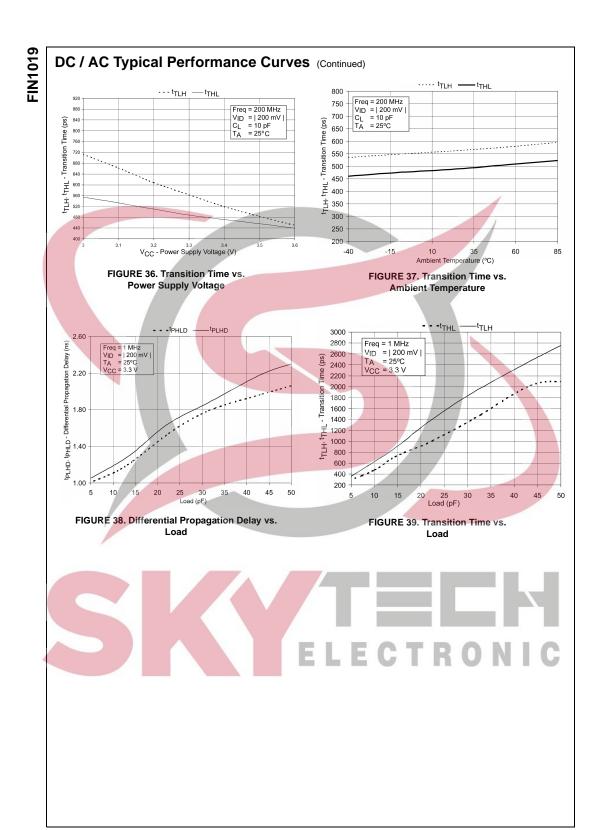




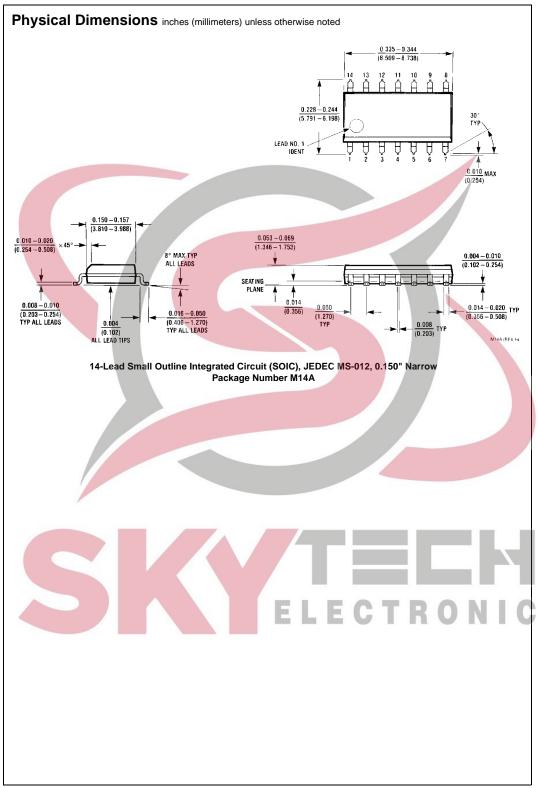


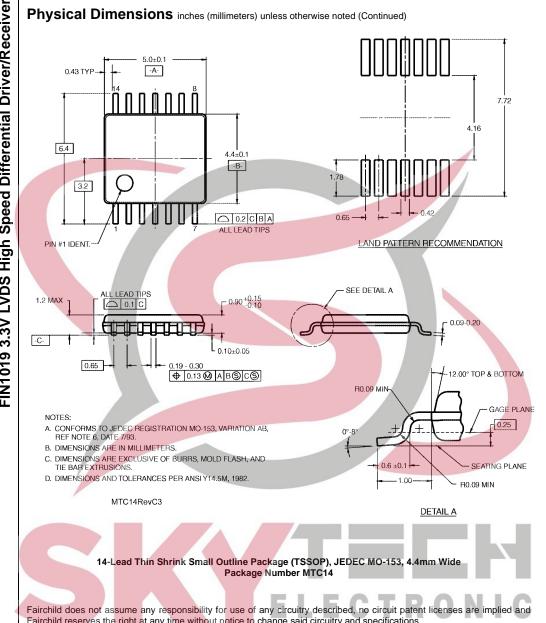






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